Search Notes



| Application/Control No. | |
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10532164

Applicant(s)/Patent Under Reexamination

KLEIN JR ET AL.

Examiner

Darren W Ark

Art Unit

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| Class | Subclass | Date | Examiner | | |
| 43 | 132.1, 131, 124 | 07/08/2008 | DA | | |
| Above | UPDATED | 12/22/0082 | DA | | |

SEARCH NOTES

| Search Notes | Date | Examiner | |
|---|------------|----------|--|
| A01M 1/00, A01M 1/02, A01M 1/10, A01M 1/20, A01M 17/00 (not U.S., | 07/08/2008 | DA | |
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INTERFERENCE SEARCH

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